ACT108W-600D AC Thyristor power switch Rev. 02 — 27 December 2010

Product data sheet

1. **Product profile**

1.1 General description

AC Thyristor power switch in a SOT223 surface-mountable plastic package with self-protective capabilities against low and high energy transients

1.2 Features and benefits

- Common terminal on mounting base allows multiple ACTs on shared cooling pad
- Exclusive negative gate triggering
- Full cycle AC conduction
- High noise immunity
- Remote gate separates the gate driver from the effects of the load current
- Safe clamping of low energy over-voltage transients
- Self-protective turn-on during high energy voltage transients
- Surface-mountable package
- Very sensitive gate for lowest gate trigger current

1.3 Applications

- Fan motor circuits
- Lower-power highly inductive, resistive and safety loads
- Pump motor circuits

1.4 Quick reference data

Quick reference data Table 1.

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V_{DRM}	repetitive peak off-state voltage		-	-	600	V
0.	gate trigger current	$V_D = 12 \text{ V; } I_T = 100 \text{ mA; LD-} G-; T_j = 25 ^{\circ}\text{C}$	0.5	-	5	mA
		$V_D = 12 \text{ V; } I_T = 100 \text{ mA; LD+}$ G-; $T_j = 25 \text{ °C; see } \frac{\text{Figure 10}}{\text{ or } 100 \text{ mA; LD+}}$	0.5	-	5	mA
I _{T(RMS)}	RMS on-state current	full sine wave; T _{sp} ≤ 112 °C; see <u>Figure 4</u> ; see <u>Figure 1</u> ; see <u>Figure 2</u>	-	-	8.0	Α
dV _D /dt	rate of rise of off-state voltage	$V_{DM} = 402 \text{ V}; T_j = 125 ^{\circ}\text{C}; \text{ gate}$ open circuit; exponential waveform; see Figure 14	300	-	-	V/µs



Table 1. Quick reference data ...continued

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V_{CL}	clamping voltage	I_{CL} = 100 μ A; t_p = 1 ms; $T_j \le$ 125 °C; see <u>Figure 17</u>	650	-	-	V
V_{PP}	peak pulse voltage	T _j = 25 °C; non-repetitive, off-state; see <u>Figure 3</u>	-	-	2	kV
V_{T}	on-state voltage	I _T = 1.1 A; see <u>Figure 13</u>	-	-	1.3	V

2. Pinning information

Table 2. Pinning information

Pin	Symbol	Description	Simplified outline	Graphic symbol
1	LD	load		1.0
2	CM	common	4	LD
3	G	gate		G-OF-
4	СМ	common	1 2 3	СМ
			SOT223 (SC-73)	001aaj924

3. Ordering information

Table 3. Ordering information

Type number	Package		
	Name	Description	Version
ACT108W-600D	SC-73	plastic surface-mounted package with increased heatsink; 4 leads	SOT223

4. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
V_{DRM}	repetitive peak off-state voltage		-	600	V
I _{T(RMS)}	RMS on-state current	full sine wave; T _{sp} ≤ 112 °C; see <u>Figure 4</u> ; see <u>Figure 1</u> ; see <u>Figure 2</u>	-	0.8	Α
I _{TSM}	non-repetitive peak on-state current	full sine wave; $T_{j(init)} = 25 \text{ °C}$; $t_p = 16.7 \text{ ms}$	-	8.8	Α
		full sine wave; $T_{j(init)} = 25 ^{\circ}\text{C}$; $t_p = 20 \text{ms}$; see Figure 5; see Figure 6	-	8	Α
I ² t	I2t for fusing	t _p = 10 ms; sine-wave pulse	-	0.32	A^2s
dI _T /dt	rate of rise of on-state current	$I_T = 1 \text{ A}$; $I_G = 10 \text{ mA}$; $dI_G/dt = 0.2 \text{ A/}\mu\text{s}$	-	50	A/µs
I _{GM}	peak gate current	t = 20 µs	-	1	Α
V_{GM}	peak gate voltage	positive applied gate voltage	-	15	V
P _{G(AV)}	average gate power	over any 20 ms period	-	0.1	W
T _{stg}	storage temperature		-40	150	°C
Tj	junction temperature		-	125	°C
V _{PP}	peak pulse voltage	$T_j = 25$ °C; non-repetitive, off-state; see Figure 3	-	2	kV

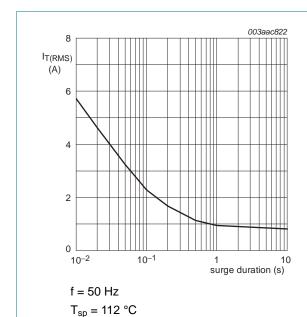


Fig 1. RMS on-state current as a function of surge duration; maximum values

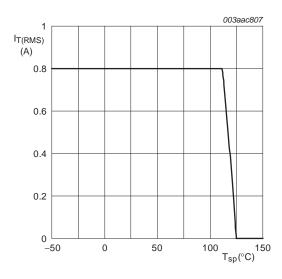


Fig 2. RMS on-state current as a function of solder point temperature; maximum values

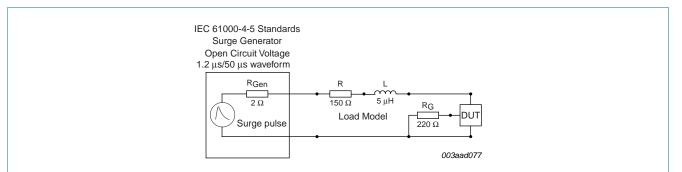


Fig 3. Test circuit for inductive and resistive loads with conditions equivalent to IEC 61000-4-5

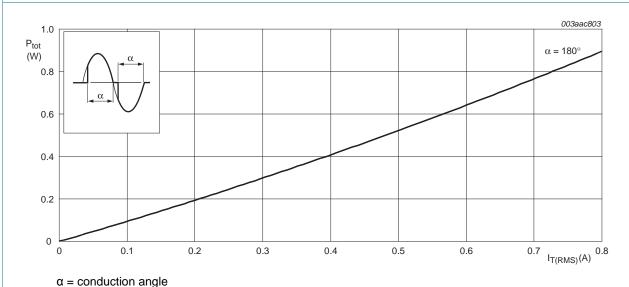


Fig 4. Total power dissipation as a function of RMS on-state current; maximum values

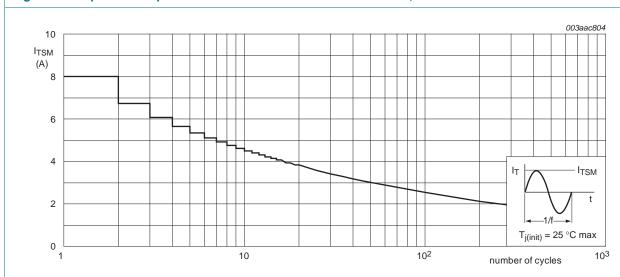
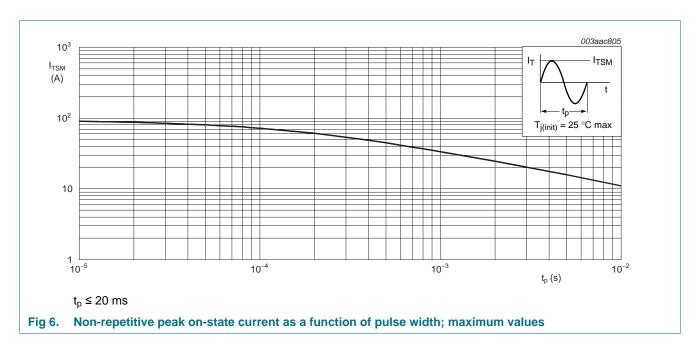


Fig 5. Non-repetitive peak on-state current as a function of the number of sinusoidal current cycles; maximum values

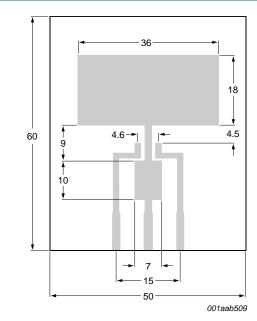
f = 50 Hz



5. Thermal characteristics

Table 5. Thermal characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$R_{th(j-sp)}$	thermal resistance from junction to solder point	full cycle with heatsink compound; see Figure 9	-	-	15	K/W
ιι() α)	thermal resistance from junction to ambient	full cycle; printed-circuit board mounted for pad area; see Figure 7	-	70	-	K/W
		full cycle; printed-circuit board mounted for minimum footprint; see Figure 8	-	156	-	K/W

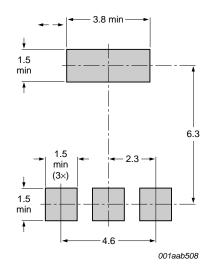


All dimensions are in mm

Printed-circuit board:

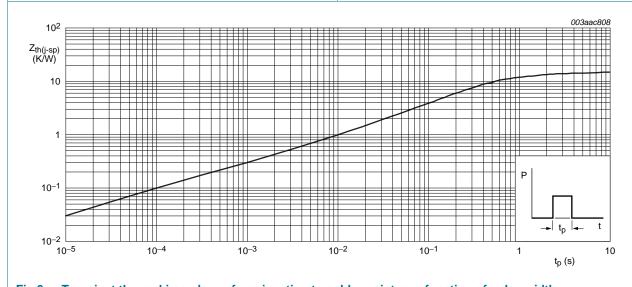
FR4 epoxy glass (1.6 mm thick), copper laminate (35 um thick).

Fig 7. Printed-circuit board pad area SOT223



All dimensions are in mm

Fig 8. Minimum footprint SOT223



6. Characteristics

Table 6. Characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
I_{GT}	gate trigger current	$V_D = 12 \text{ V; } I_T = 100 \text{ mA; LD- G-;}$ $T_j = 25 \text{ °C}$	0.5	-	5	mA
		$V_D = 12 \text{ V; } I_T = 100 \text{ mA; LD+ G-;}$ $T_j = 25 \text{ °C; see } \frac{\text{Figure 10}}{\text{ or } 100 \text{ mA; LD+ G-;}}$	0.5	-	5	mA
I <u>L</u>	latching current	$V_D = 12 \text{ V}; I_G = 12 \text{ mA}; T_j = 25 ^{\circ}\text{C};$ see Figure 11	-	-	25	mA
I _H	holding current	$V_D = 12 \text{ V; } T_j = 25 \text{ °C; see } \frac{\text{Figure } 12}{}$	-	-	20	mA
V_{T}	on-state voltage	I _T = 1.1 A; see <u>Figure 13</u>	-	-	1.3	V
V_{GT}	gate trigger voltage	$V_D = 12 \text{ V}; I_T = 100 \text{ mA}; T_j = 25 \text{ °C}$	-	-	0.9	V
		$V_D = 12 \text{ V}; I_T = 100 \text{ mA}; T_j \le 125 \text{ °C}$	0.15	-	-	V
I_D	off-state current	V _D = 600 V; T _j ≤ 25 °C	-	-	2	μA
		V _D = 600 V; T _j ≤ 125 °C	-	-	0.2	mA
dV _D /dt	rate of rise of off-state voltage	V_{DM} = 402 V; T_j = 125 °C; gate open circuit; exponential waveform; see Figure 14	300	-	-	V/µs
dl _{com} /dt	rate of change of commutating current	$V_D = 400 \text{ V; } T_j = 125 \text{ °C; } I_{T(RMS)} = 1 \text{ A;}$ $dV_{com}/dt = 15 \text{ V/}\mu\text{s; gate open circuit;}$ $see \underline{Figure 15}$; $see \underline{Figure 16}$	0.15	-	-	A/ms
V_{CL}	clamping voltage	I_{CL} = 100 μ A; t_p = 1 ms; $T_j \le$ 125 °C; see Figure 17	650	-	-	V

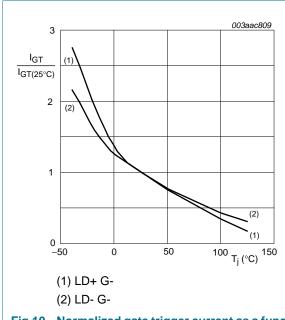


Fig 10. Normalized gate trigger current as a function of junction temperature

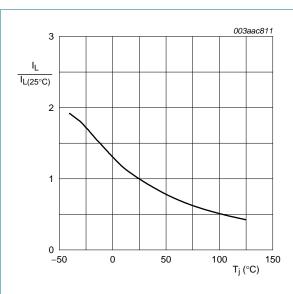
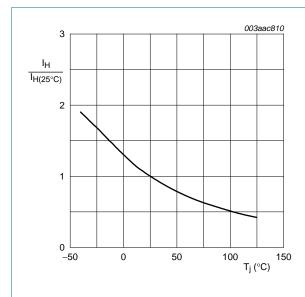
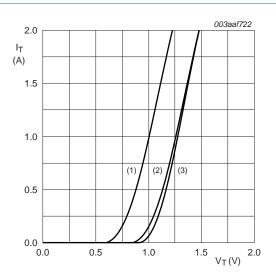


Fig 11. Normalized latching current as a function of junction temperature





 $V_o = 0.758 \, V$ $R_s = 0.263 \, \Omega$

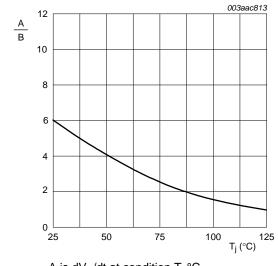
(1) $T_j = 125$ °C; typical values

(2) $T_j = 125 \,^{\circ}\text{C}$; maximum values

(3) $T_j = 25$ °C; maximum values

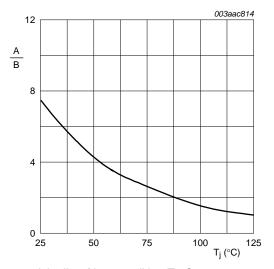
Fig 12. Normalized holding current as a function of junction temperature





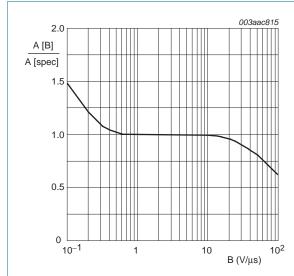
A is dV_D/dt at condition T_j °C B is dV_D/dt at condition T_i 125 °C

Fig 14. Normalized rate of rise of off-state voltage as a function of junction temperature



A is dI_{com}/dt at condition T_j °C B is dI_{com}/dt at condition T_j 125 °C $V_D = 400 \ V$

Fig 15. Normalized critical rate of rise of commutating current as a function of junction temperature



A[B] is dI_{com}/dt at condition B, dV_{com}/dt A[spec] is the specified data sheet value of dI_{com}/dt turn-off time < 20 ms

Fig 16. Normalized critical rate of change of commutating current as a function of critical rate of change of commutating voltage; minimum values

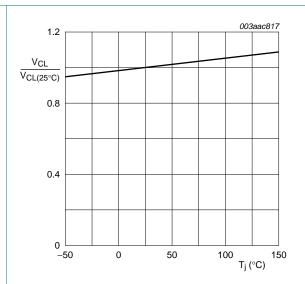


Fig 17. Normalized clamping voltage (upper limit) as a function of junction temperature; minimum values

7. Package outline

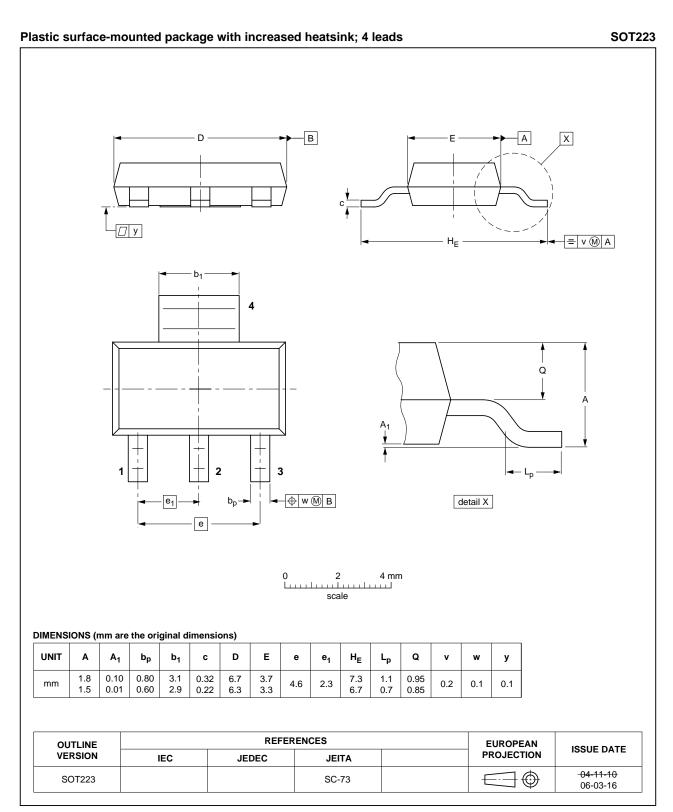
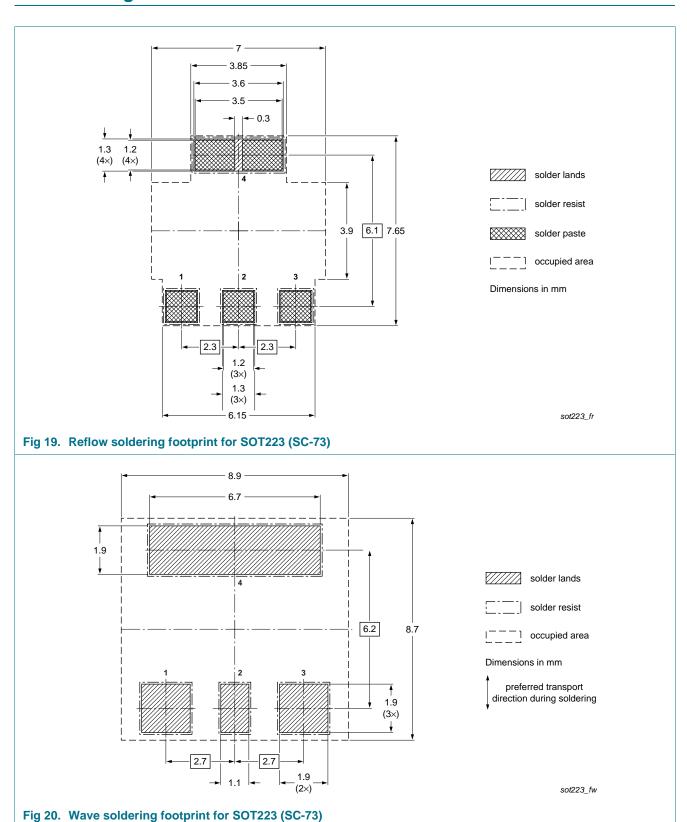


Fig 18. Package outline SOT223 (SC-73)

ACT108W-600D

8. Soldering



9. Revision history

Table 7. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
ACT108W-600D v.2	20101227	Product data sheet	-	ACT108W-600D v.1
Modifications:	 Status changed f 	rom Preliminary to Produc	t.	
	 Various changes 	to content.		
ACT108W-600D v.1	20100902	Preliminary data sheet	-	-

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Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
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Product [short] data sheet	Production	This document contains the product specification.

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